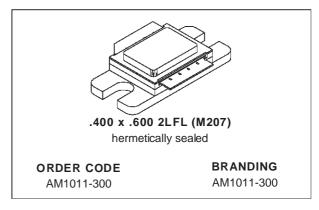


AM1011-300

RF & MICROWAVE TRANSISTORS AVIONICS APPLICATIONS

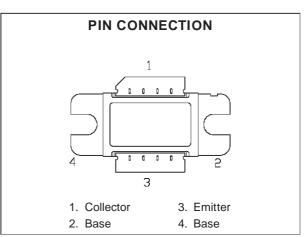
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTING
- LOW RF THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- Pout = 325 W MIN. WITH 7.7 dB GAIN
- 1030/1090 MHZ OPERATION



DESCRIPTION

The AM1011-300 is a rugged, Class C common base device specifically designed for new Mode-S interrogator and transponder applications.

Minimal amplitude droop over the heavy Mode-S pulse burst is guaranteed by a thermal design incorporating an overlay site-ballasted die geometry.



ABSOLUTE MAXIMUM RATINGS (T_{case} = 25°C)

Symbol	Parameter	Value	Unit
P _{DISS}	Power Dissipation (T _C ≤100°C)*	1070	W
Ic	Device Current*	36	A
V _C C	Collector-Supply Voltage*	43	V
TJ	Junction Temperature (Pulsed RF operation)	+250	°C
T _{STG}	Storage Temperature	- 65 to +200	°C

THERMAL DATA

R _{TH(j-c)}	Junction-Case Thermal Resistance*	0.14	°C/W
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^{*}Applies only to rated RF amplifier operation.

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ELECTRICAL SPECIFICATIONS (T_{case} = 25°C)

STATIC

Symbol	Test Conditions	Value			I Imit		
		Min.	Тур.	Max.	Unit		
ВУсво	I _C = 75 mA	$I_E = 0 \text{ mA}$		65		_	V
BV _{CES}	I _C = 75 mA	$V_{BE} = 0 V$		65	_	_	V
BV _{EBO}	I _C = 25 mA	$I_C = 0 \text{ mA}$		3.0		_	V
I _{CES}	V _{CE} = 40 V	$V_{BE} = 0 V$		_		30	mA
hFE	V _{CE} = 5 V	I _C = 10 A		10	_	_	_

DYNAMIC

Symbol		Test Conditions		Value			Unit
Symbol	rest conditions		Min.	Тур.	Max.	Onn	
Роит	f = 1090 MHz	$P_{IN} = 55 \text{ W}$	$V_{CC} = 40 \text{ V}$	325	350	_	W
hc	f = 1090 MHz	P _{OUT} = 325 W	$V_{CC} = 40 \text{ V}$	40	45	_	%
G _P	f = 1090 MHz	P _{OUT} = 325 W	V _{CC} = 40 V	7.7	8.0	_	dB

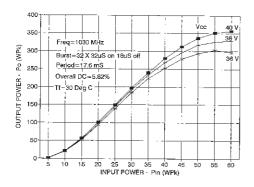
Pulse Conditions: Pulse width = $200\mu s$, Duty Cycle = 5%, are equivalent to the following pulse burst conditions:

Mode-S Interrogator (freq = 1030MHz) 32 pulses, 32μs on, 18μs off, burst period = 17.6ms

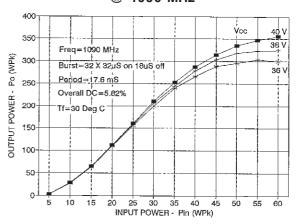
long term duty = 5.82%

TYPICAL PERFORMANCE

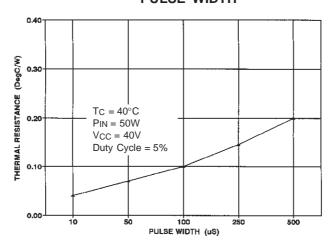
POWER OUTPUT vs POWER INPUT @ 1030 MHz



POWER OUTPUT vs POWER INPUT @ 1090 MHz

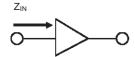


MAXIMUM THERMAL RESISTANCE vs PULSE WIDTH

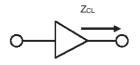


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE



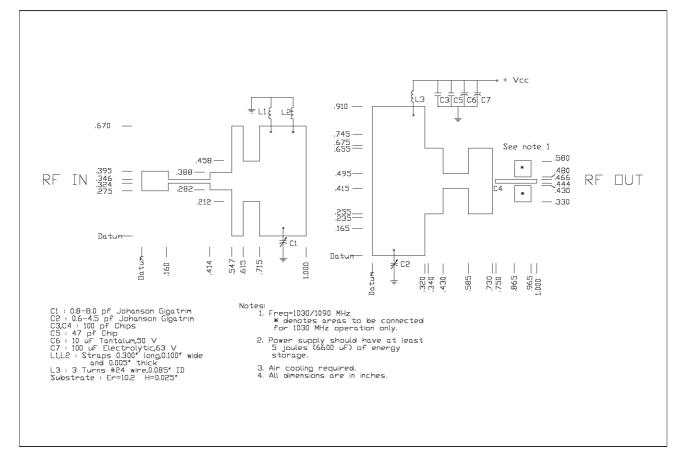
TYPICAL COLLECTOR LOAD



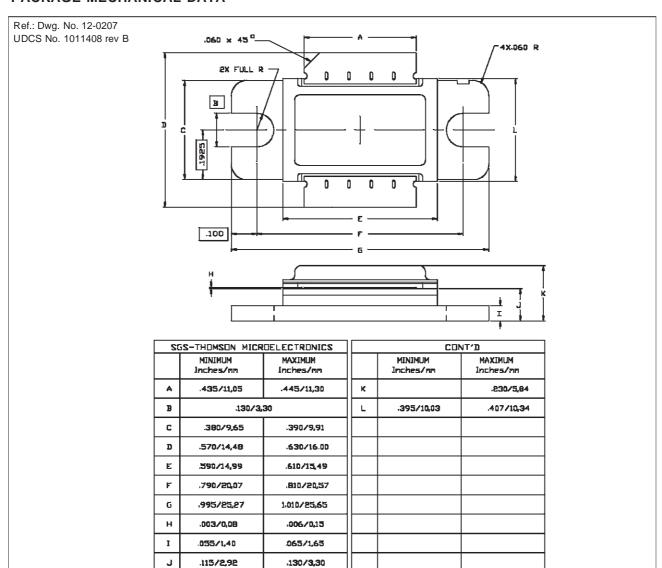
FREQ.	$Z_{IN}(\Omega)$	$Z_{CL}(\Omega)$
1030 MHz	0.7 + j 4.1	0.78 – j 2.4
1090 MHz	0.65 + j 4.2	0.4 – j 2.4

 $P_{IN} = 55W$

TEST CIRCUIT



PACKAGE MECHANICAL DATA



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